

AOT462L/AOB462L

60V N-Channel MOSFET

General Description

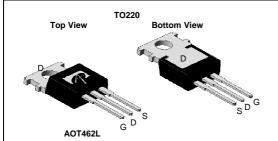
The AOT462L/AOB462L combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

 $\begin{array}{ll} V_{DS} & 60V \\ I_D \ (at \ V_{GS} \! = \! 10V) & 35A \\ R_{DS(ON)} \ (at \ V_{GS} \! = \! 10V) & < 18m\Omega \end{array}$

100% UIS Tested 100% R_g Tested

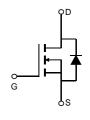




Junction and Storage Temperature Range



-55 to 175



Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain	T _C =25℃		35		
Current G	T _C =100℃	I _D	27	A	
Pulsed Drain Current ^Ĉ		I _{DM}	120		
Continuous Drain	T _A =25℃		7	^	
Current	T _A =70℃	IDSM	6	A	
Avalanche Current ^C		I _{AS} , I _{AR}	26	Α	
Avalanche energy L=0.3mH ^C		E _{AS} , E _{AR}	101	mJ	
	T _C =25℃	D	100	W	
Power Dissipation ^B	T _C =100℃	P _D	50	VV	
	T _A =25℃	Ь	2.1	10/	
Power Dissipation A	T _A =70℃	P _{DSM}	1.3	W	

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	45	60	€/M			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.25	1.5	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units	
STATIC F	PARAMETERS							
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		60			V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V				1	μА	
	Zero Gate Voltage Drain Gurrent				5			
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$		2	3.1	4	V	
I _{D(ON)}	On state drain current	V_{GS} =10V, V_{DS} =5V		120			Α	
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_{D} =30A			14.5	18	mΩ	
		TO220	T _J =125℃		25	30	11152	
		V_{GS} =10V, I_{D} =30A			14.2	17.7		
		TO263	T _J =125℃		24.5	30	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =30A		50		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.73	1	V		
Is	Maximum Body-Diode Continuous Curr			35	Α			
DYNAMIC	PARAMETERS							
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz			1840	2400	pF	
C _{oss}	Output Capacitance				185		pF	
C _{rss}	Reverse Transfer Capacitance				80		pF	
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			2.8	4.2	Ω	
SWITCHI	NG PARAMETERS							
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =30A			27.8	36	nC	
Q_{gs}	Gate Source Charge				9.9		nC	
Q_{gd}	Gate Drain Charge				6.6		nC	
t _{D(on)}	Turn-On DelayTime				12		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =30V, R_L =1 Ω , R_{GEN} =3 Ω			5.2		ns	
t _{D(off)}	Turn-Off DelayTime				38		ns	
t _f	Turn-Off Fall Time				27		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =30A, dI/dt=100A/μs			35	64	ns	
Q_{rr}	Body Diode Reverse Recovery Charge I _F =30A, dl/dt=100A/μs				47	62	nC	

A. The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150° $\,$ C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

 F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current limited by package.

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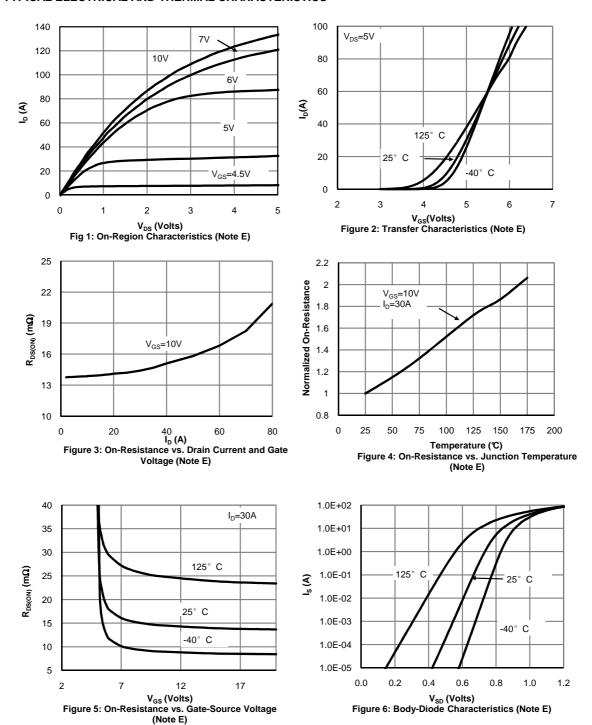
B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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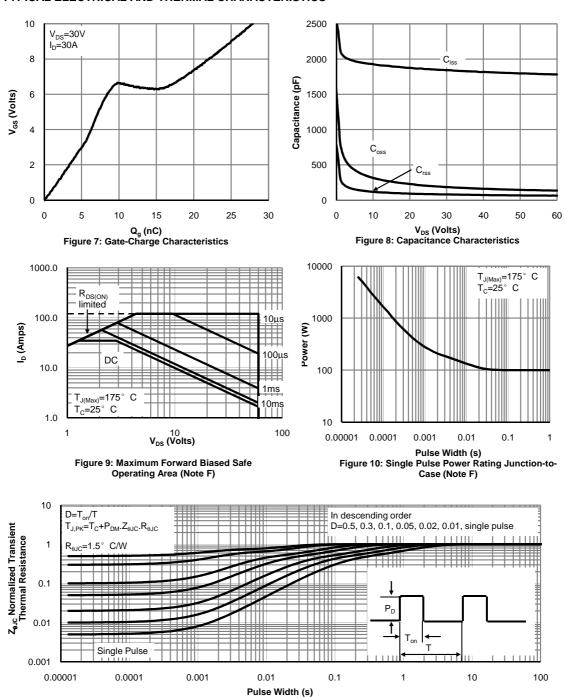
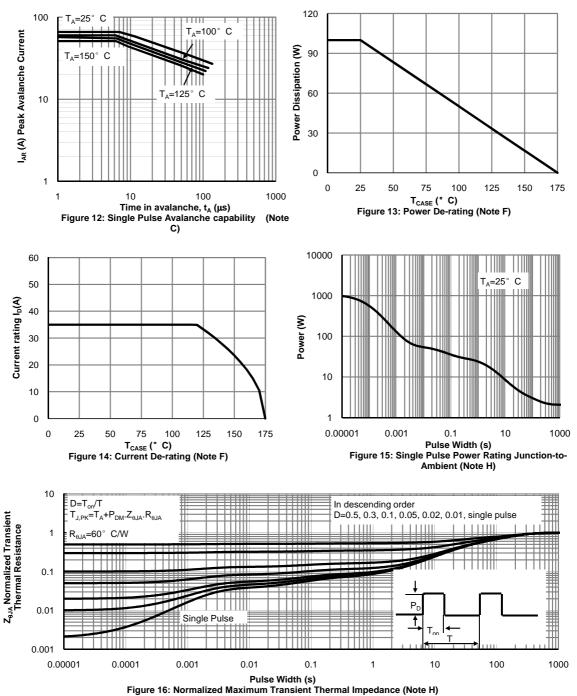


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

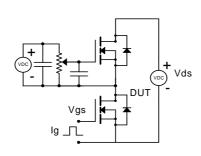


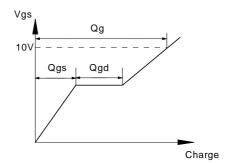
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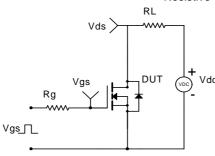


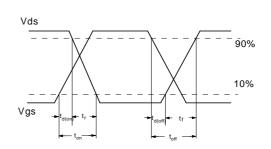
Gate Charge Test Circuit & Waveform



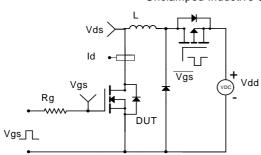


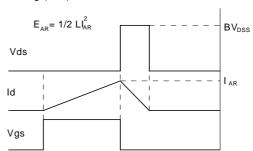
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

